

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under  
Reexamination  
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Examiner

BENJAMIN E. LANIER

Art Unit

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**U.S. PATENT DOCUMENTS**

★		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
★	A	US-6,246,803 B1	06-2001	Gauch, John M.	382/276
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	K	US-			
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**FOREIGN PATENT DOCUMENTS**

★		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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